

N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (mΩ) (Typ.)	I _D (A)	Q _g (Typ.)			
200	7.3 at V _{GS} = 10 V	185	89 nC			

TOLL Pin Configuration

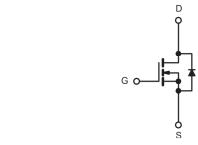
FEATURES

- DT-Trench II Power MOSFET
- 100 % R_g and UIS tested
- Extremely Low R_{DS(ON)}

Pb RoHS

APPLICATIONS

- Synchronous Rectification
- Motor Drives and Uninterruptible Power Supplies



N-Channel MOSFET

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V _{DS}	200	V	
Gate-Source Voltage		V _{GS}	± 20		
0-sti	T _C = 25 °C		185	^	
Continuous Drain Current (T _J = 150 °C)	T _C = 100 °C		138		
Pulsed Drain Current (t = 100 μs)		I _{DM}	740	A	
Avalanche Current	L = 0.1 mH	I _{AS}	180		
Single Avalanche Energy ^a	L = 0.1 IIII	E _{AS}	968	mJ	
Maximum Power Dissipation ^a	T _C = 25 °C	P _D	527 ^b	· w	
Maximum Fower Dissipation ~	T _C = 100 °C		105.8 ^b		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C	

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	LIMIT	UNIT	
Junction-to-Ambient (PCB Mount) ^c	t ≤ 10 s	R _{thJA}	55	°C/W	
Junction-to-Case (Drain)	Steady State	R _{thJC}	0.5	- °C/W	

Notes

- a. Duty cycle ≤ 1 %.
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR4 material).



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	200	-	-	V
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	-	4	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zara Cata Valtana Desir O	I _{DSS}	V _{DS} = 200 V, V _{GS} = 0 V	-	-	1	μА
Zero Gate Voltage Drain Current		V _{DS} = 160 V, V _{GS} = 0 V, T _J = 100 °C	-	-	50	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	185	-	-	Α
Drain-Source On-State Resistance a	R _{DS(on)}	V _{GS} = 10 V, I _D = 30 A	-	7.3	8.5	mΩ
Forward Transconductance a	9 _{fs}	$V_{DS} = 5 \text{ V}, I_{D} = 30 \text{ A}$	-	78	-	S
Dynamic ^b				•		
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 100 V, f = 1 MHz	-	9689	-	pF
Output Capacitance	C _{oss}		-	1257	-	
Reverse Transfer Capacitance	C _{rss}		-	26	-	
Total Gate Charge ^c	Qg		-	89	-	nC
Gate-Source Charge ^c	Q _{gs}	V _{DS} = 100 V, V _{GS} = 10 V, I _D = 30 A	-	37	-	
Gate-Drain Charge ^c	Q _{gd}		-	10	-	
Gate Resistance	R _g	f = 1 MHz	-	1.5	-	Ω
Turn-On Delay Time ^c	t _{d(on)}	V_{DD} = 100 V, I_{D} = 30 A, R_{g} = 6 Ω V _{GS} = 10 V	-	30	-	
Rise Time ^c	t _r		-	66	-	ns
Turn-Off Delay Time ^c	t _{d(off)}		-	78	-	
Fall Time ^c	t _f		-	19	-	
Drain-Source Body Diode Ratings and	Characterist	ics ^b (T _C = 25 °C)				
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	185	А
Pulsed Current (t = 100 µs)	I _{SM}		-	-	740	Α
Forward Voltage ^a	V _{SD}	I _F = 30 A, V _{GS} = 0 V	-	-	1.25	V
Reverse Recovery Time	t _{rr}	1 20 4 41/44 100 4/	-	106	-	ns
Reverse Recovery Charge	Q _{rr}	I _F = 30 A, di/dt = 100 A/μs	-	339	_	nC

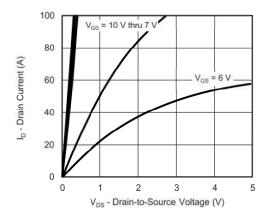
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

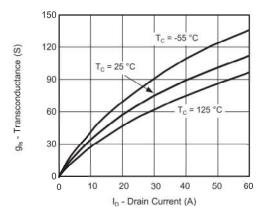
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



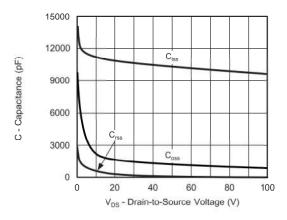
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



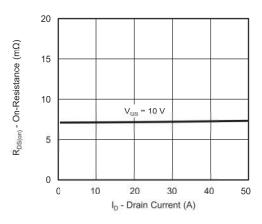
Output Characteristics



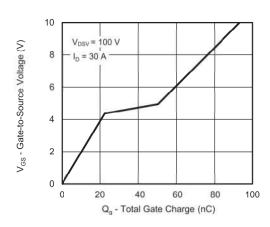
Transconductance



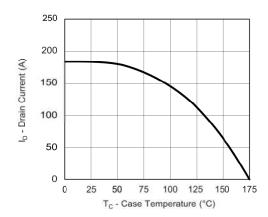
Capacitance



On-Resistance vs. Drain Current

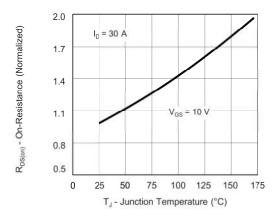


Gate Charge

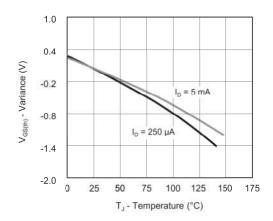


Current De-Rating

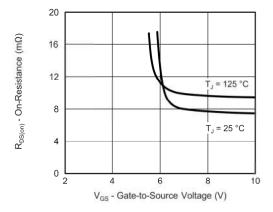
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



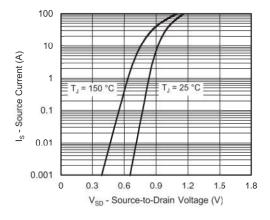
On-Resistance vs. Junction Temperature



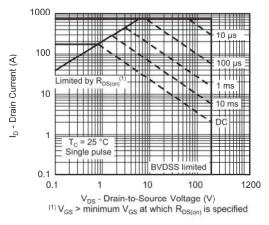
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

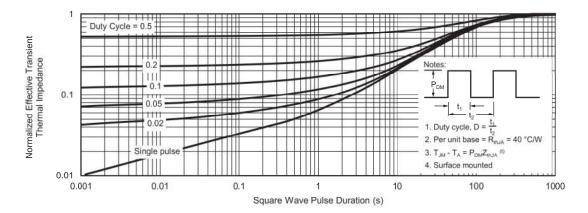


Source Drain Diode Forward Voltage



Safe Operating Area

THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient





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